### Innovating Energy Technology

# FML60N191S2FDHF

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**FUJI POWER MOSFET** 

# Super J MOS® S2 series

#### N-Channel enhancement mode power MOSFET

#### Features

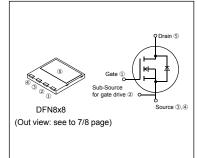
Pb-free lead terminal RoHS compliant Halogen-free molding compound MSL:1, Reflow available

#### Applications

For switching



### Package and Internal circuit chart



#### ■ Absolute Maximum Ratings at T<sub>c</sub>=25°C (unless otherwise specified)

Parameter	Symbol	Characteristics	Unit	Remarks
Proin Course Voltons	<b>V</b> DS	600	V	
Drain-Source Voltage	<b>V</b> <sub>DSX</sub>	600	V	V <sub>GS</sub> =-30V
Ocations and David Ocament	,	22.7	Α	<i>T</i> <sub>c</sub> =25°C Note*1,2
Continuous Drain Current	<b>I</b> □	14.3	Α	T <sub>c</sub> =100°C Note*1,2
Pulsed Drain Current	<b>I</b> DP	66.0	Α	Note *2
Gate-Source Voltage	<b>V</b> <sub>GS</sub>	±30	V	
Non-Repetitive Maximum Avalanche Current	<b>I</b> AS	2.7	А	Note *3
Non-Repetitive Maximum Avalanche Energy	<b>E</b> as	391.1	mJ	Note *4
Maximum MOSFET dv/dt	d <i>v</i> ⊳s/d <i>t</i>	50	V/ns	V <sub>DS</sub> ≤ 600V
Continuous	,	22.7	Α	<i>T</i> <sub>c</sub> =25°C Note*1,2
Diode Forward Current	<b>I</b> DR	14.3	Α	T <sub>c</sub> =100°C Note*1,2
Pulsed Diode Forward Current	<b>I</b> DRP	66.0	Α	Note *2
Peak Diode Recovery dv/dt	d <i>v</i> /d <i>t</i>	30	V/ns	Note *5
Peak Diode Recovery -dipr/dt	-di <sub>DR</sub> /dt	100	A/µs	Note *6
Marrian Danier Discipation	Ptot	127	W	<i>T</i> <sub>c</sub> =25°C
Maximum Power Dissipation	<b>Γ</b> tot	2.78	W	<i>T</i> <sub>a</sub> =25°C
Operating Channel Temperature	<b>T</b> ch	150	°C	
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C	

Note \*1 : Maximum duty cycle D=0.53

Note 1. Maximum duty cycle D=0.50 Note \*2 : Limited by maximum channel temperature. Note \*3 :  $T_{ch} \le 150$  °C, See Figure 1 and 2. Note \*4 : Starting  $T_{ch} = 25$  °C,  $I_{ch} = 1.7$  A, L = 248 mH,  $V_{ch} = 60$  V,  $I_{ch} = 50$   $I_{ch} = 1.7$  A, L = 248 mH,  $I_{ch} = 1.7$  A, L = 248 mH,  $I_{ch} = 1.7$  A, See Figure 1 and 2. Eas limited by maximum channel temperature and avalanche current.

Note \*5 :  $I_{\rm DR} \le 17.9~{\rm A}$  ,  $-d_{\rm DR}/dt \le 100~{\rm A/ys}$ ,  $V_{\rm DS}$  peak  $\le 600~{\rm V}$ ,  $T_{\rm ch} \le 150~{\rm ^{\circ}C}$ . Note \*6 :  $I_{\rm DR} \le 17.9~{\rm A}$  ,  $d_{\rm V}/dt \le 30~{\rm V/ns}$ ,  $V_{\rm DS}$  peak  $\le 600~{\rm V}$ ,  $T_{\rm ch} \le 150~{\rm ^{\circ}C}$ .

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# ■ Electrical Characteristics at *T*<sub>c</sub>=25°C (unless otherwise specified) • Static characteristics

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{\text{GS}} = 0 \text{ V}$ $I_{\text{D}} = 250  \mu\text{A}$		600	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ $I_D = 2.7 \text{ mA}$		3.0	4.0	5.0	V
Zero Gate Voltage Drain Current	Ibss	V <sub>DS</sub> = 600 V V <sub>GS</sub> = 0 V	T <sub>ch</sub> = 25 °C	-	-	25	μΑ
		V <sub>DS</sub> = 480 V V <sub>GS</sub> = 0 V	T <sub>ch</sub> = 125 °C	-	-	-	
Gate-Source Leakage Current	<b>I</b> GSS	V <sub>DS</sub> = 0 V V <sub>GS</sub> = ± 30 V		-	10	100	nA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 4.5 A		-	0.171	0.191	Ω
Gate resistance	r <sub>g</sub>	f = 1 MHz, open drain		-	9.8	-	Ω

#### • Dynamic characteristics

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Forward Transconductance	<b>g</b> fs	$V_{DS} = 25 \text{ V}$ $I_D = 9.0 \text{ A}$	3.2	13	-	S
Input Capacitance	Ciss	V <sub>DS</sub> = 400 V	-	940	-	
Output Capacitance	Coss	$V_{GS} = 0 \text{ V}$	-	34	-	
Reverse Transfer Capacitance	Crss	f = 250 kHz	-	5.2	-	
Effective output capacitance, energy related (Note *7)	C <sub>o(er)</sub>	V <sub>DS</sub> = 0400 V V <sub>GS</sub> = 0 V	-	83	-	pF
Effective output capacitance, time related (Note *8)	C <sub>o(tr)</sub>	V <sub>DS</sub> = 0400 V V <sub>GS</sub> = 0 V I <sub>D</sub> = constant	-	321	-	
Turn-On Time	t <sub>d(on)</sub>	$V_{DD} = 400 \text{ V}, V_{GS} = 10 \text{ V}$ $I_D = 9.0 \text{ A},$	-	26	-	
Turn-On Time	<b>t</b> r		-	11	-	20
Turn-Off Time	t <sub>d(off)</sub>	$R_{\rm G}$ = 36 $\Omega$ See Figure 3 and 4	-	209	-	ns
	<b>t</b> f		-	22	-	
Total Gate Charge	Q <sub>G</sub>	$V_{DD} = 400 \text{ V}, V_{GS} = 10 \text{ V}$	-	48	-	
Gate-Source Charge	Q <sub>GS</sub>	$I_b = 17.9 \mathrm{A}$ See Figure 5	-	17	-	nC
Gate-Drain Charge	Q <sub>GD</sub>		-	21	-	

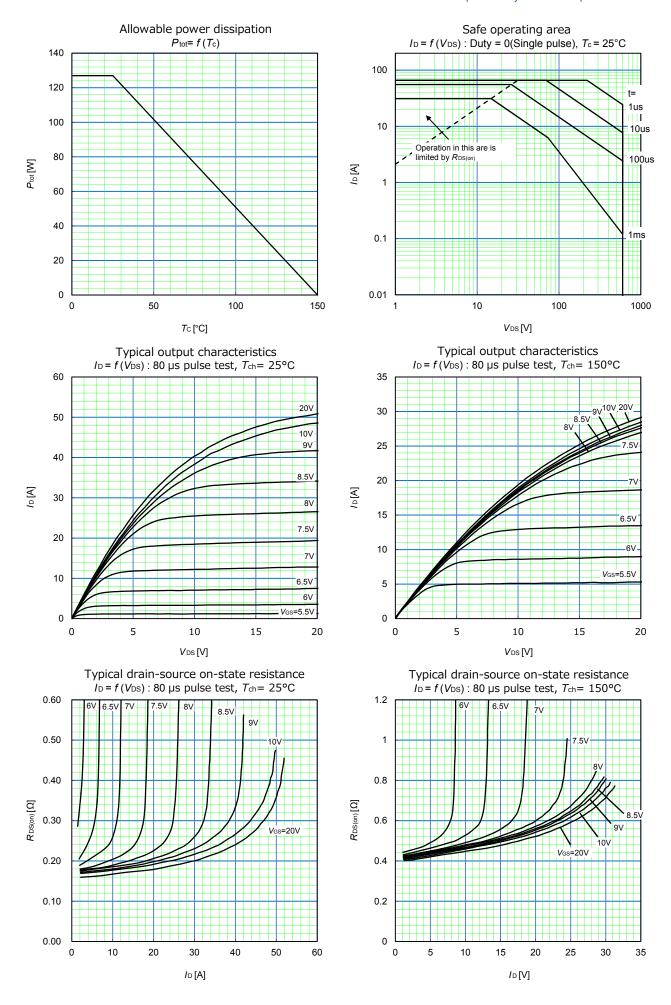
Note \*7 :  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{OS}}$  is rising from 0 to 400 V. Note \*8 :  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same charging times as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400 V.

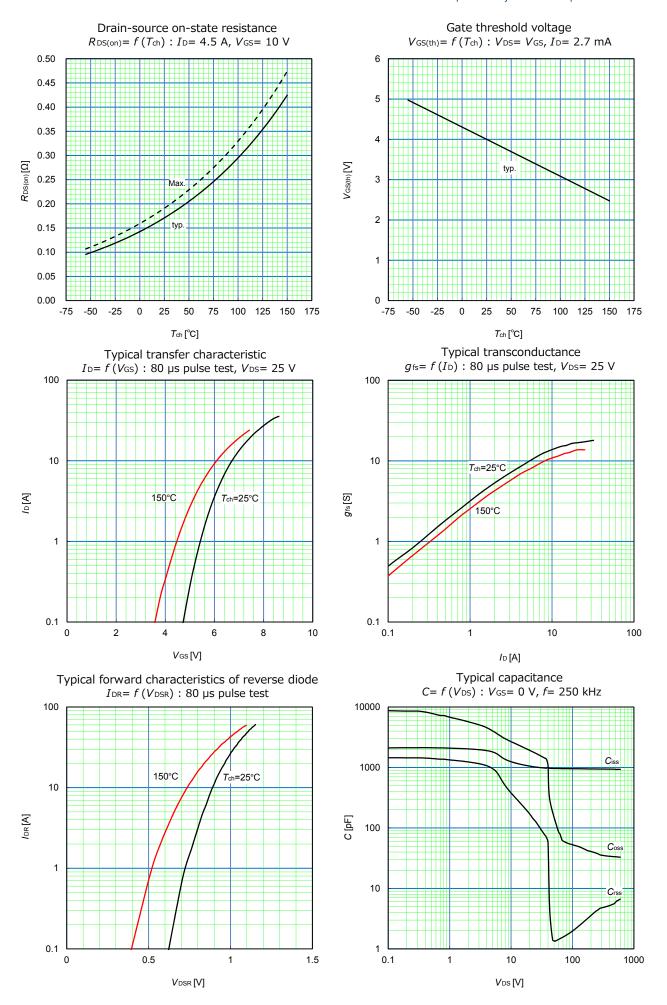
#### • Reverse diode characteristics

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Diode Forward On-Voltage	<b>V</b> <sub>DSR</sub>	I <sub>DR</sub> = 17.9 A, V <sub>GS</sub> = 0 V T <sub>ch</sub> = 25 °C	-	1.00	1.35	V
Reverse Recovery Time	<b>t</b> rr	V <sub>DD</sub> = 400 V I <sub>DR</sub> = 17.9 A V <sub>SS</sub> = 0 V -di <sub>DR</sub> /dt = 100 A/µs T <sub>ch</sub> = 25 °C See Figure 6 and 7	-	150	-	ns
Reverse Recovery Charge	Qrr		-	1	-	μC
Peak Reverse Recovery Current	<b>I</b> rrm		-	12.9	-	Α

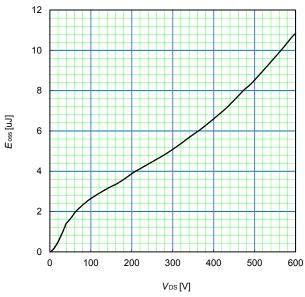
#### ■ Thermal Resistance

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Thermal Resistance, Channel – Ambient	Rth(ch-a)	Device mounted on PCB (FR4) Size: 40mm*40mm*1.5mm with 6cm² copper area (one layer, 70µm thickness) for drain connection and cooling.	-	-	45	°C/W
Thermal Resistance, Channel – Case	R <sub>th(ch-c)</sub>		-	-	0.984	°C/W

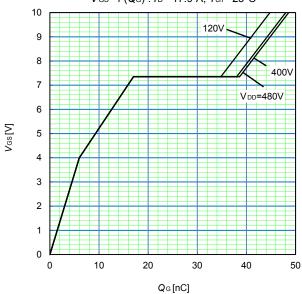




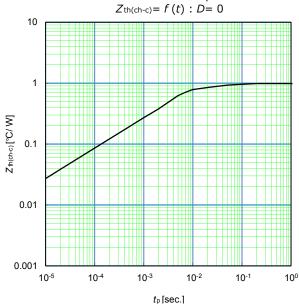




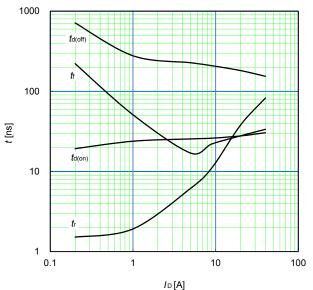
# Typical gate charge $V_{GS} = f(Q_G)$ : $I_D = 17.9$ A, $T_{Ch} = 25$ °C



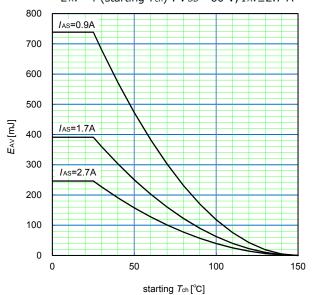
### Transient Thermal Impedance



Typical switching times vs.  $I_D$  t=  $f(I_D)$  :  $V_{DD}$ = 400 V,  $V_{GS}$ = 10 V/0 V,  $R_G$ = 36  $\Omega$ ,  $T_{Ch}$ = 25°C



Maximum Avalanche Energy  $E_{AV} = f$  (starting  $T_{Ch}$ ):  $V_{DD} = 60 \text{ V}$ ,  $I_{AV} \le 2.7 \text{ A}$ 



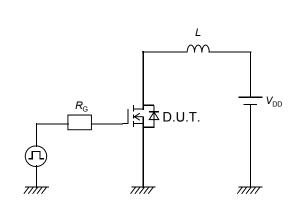


Figure 1. Unclamped inductive load test circuit

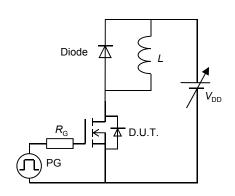


Figure 3. Switching test circuit

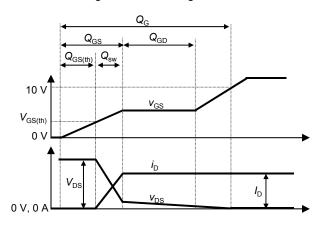


Figure 5. Gate charge waveform

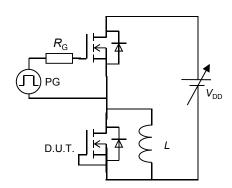


Figure 6. Diode reverse recovery test circuit

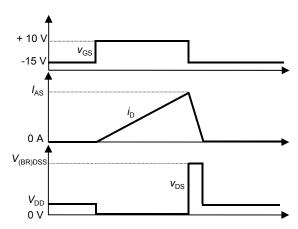


Figure 2. Unclamped inductive waveform

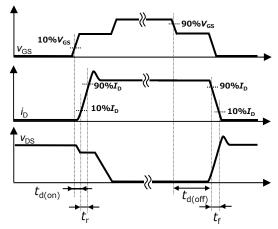


Figure 4. Switching times waveform

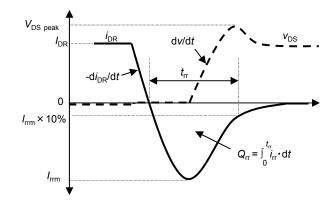
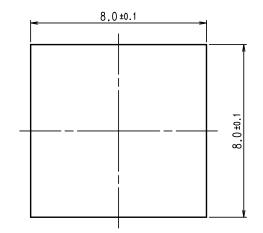
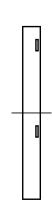
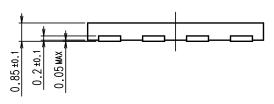


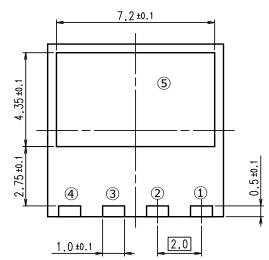
Figure 7. Diode reverse recovery waveform

#### ■ Package Dimensions : DFN8x8 Package









#### **CONNECTION**

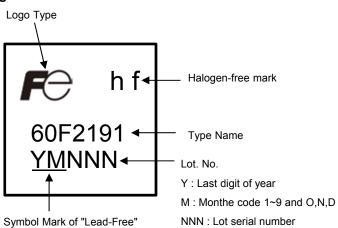
- ① Gate
- 2 Sub-Source for Gate Drive
- 3,4 Source
- **5** DRAIN

**DIMENSIONS ARE IN MILLIMETERS** 

#### Notes

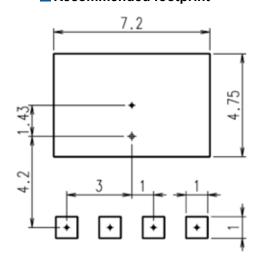
- 1.(): Reference dimensions.
- The metal part is covered with the solder plating, part of cutting is without the solder plating.

#### Marking



# \* The font (font type,size) and the trademark-size might be actually different.

#### ■ Recommended footprint



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